

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10724701	ACCARIE ET AL.
	Examiner	Art Unit
	Liu, Lin	2145

SEARCHED

Class	Subclass	Date	Examiner
709	223, 245	06/28/2007	L.L

SEARCH NOTES

Search Notes	Date	Examiner
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	06/28/2007	L.L
L1: 709/223,245.ccls. and (@ad<20021203) reviewed consicely	06/28/2007	L.L
709/223,245.ccls. not L1, reviewed cursory.	06/28/2007	L.L
Diaglog search attached	06/28/2007	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	04/23/2008	L.L

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner